Application/Control No. O9/844,757 Applicant(s)/Patent Under Reexamination SHIM, JAE H. Examiner TAN TRINH Applicant(s)/Patent Under Reexamination SHIM, JAE H. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,646,979	07-1997	Knuth, Stephen B.	455/563
	В	US-5,526,406 A	06-1996	Luneau, David J.	455/563
	С	US-5,265,264 A	11-1993	Dzung et al.	455/90.2
	D	US-6,408,177 B1	06-2002	Parikh et al.	455/414.4
	Ε	US-5,854,826 A	12-1998	Kim, Dong-Woo	379/68
	F	US-6,038,441 A	03-2000	Slaven et al.	455/413
	G	US-4,899,358	02-1990	Blakley, James R.	379/284
	Н	US-2003/0068020 A1	04-2003	Hamrick et al.	379/88.21
	_	US-5,117,449 A	05-1992	Metroka et al.	455/552.1
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.